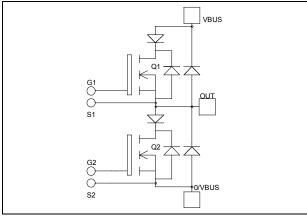
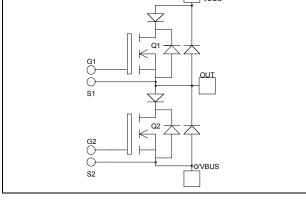
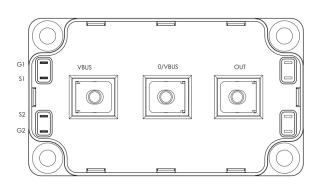


## Phase leg Series & SiC parallel diodes MOSFET Power Module







 $V_{DSS} = 500V$  $R_{DSon} = 24m\Omega \text{ typ } @ \text{Tj} = 25^{\circ}\text{C}$  $I_D = 150A$  (a) Tc = 25°C

### **Application**

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### **Features**

- Power MOS 7<sup>®</sup> MOSFETs
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Avalanche energy rated
  - Very rugged

### Parallel SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
- High level of integration

### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- **RoHS Compliant**

## All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		500	V
$I_D$	Continuous Drain Current	$T_c = 25^{\circ}C$	150	
	Continuous Drain Current	$T_c = 80$ °C	110	A
$I_{DM}$	Pulsed Drain current	600		
$V_{GS}$	Gate - Source Voltage	±30	V	
$R_{DSon}$	Drain - Source ON Resistance		28	$m\Omega$
$P_D$	Maximum Power Dissipation $T_c = 25^{\circ}C$		1250	W
$I_{AR}$	Avalanche current (repetitive and non repetitive)		24	A
E <sub>AR</sub>	Repetitive Avalanche Energy		30	T
$E_{AS}$	Single Pulse Avalanche Energy		1300	mJ

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 500V$			500	μΑ
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 75A$		24	28	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 6mA$	3		5	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±600	nA

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$		19.6		
$C_{oss}$	Output Capacitance	$V_{\rm DS} = 25V$		4.2		nF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz		0.3		
$Q_{g}$	Total gate Charge	$V_{GS} = 10V$		434		
$Q_{gs}$	Gate – Source Charge	$V_{\rm Bus} = 250 V$		120		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 150A$		216		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C		10		
$T_{\rm r}$	Rise Time	$V_{GS} = 15V$		17		ns
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 333V$ $I_D = 150A$ $R_G = 0.8\Omega$		50		
$T_{\mathrm{f}}$	Fall Time			41		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C V <sub>GS</sub> = 15V, V <sub>Bus</sub> = 333V		1.15		mJ
$E_{\text{off}}$	Turn-off Switching Energy	$I_{\rm D} = 150 A, R_{\rm G} = 0.8 \Omega$		1.5		1113
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		1.97		mJ
$E_{\text{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 333V$ $I_D = 150A, R_G = 0.8\Omega$		1.7		1113
$R_{thJC}$	Junction to Case Thermal Resistance				0.1	°C/W

Series diode ratings and characteristics

Symbol	Characteristic Test Conditions		Min	Typ	Max	Unit		
$V_{RRM}$	Maximum Peak Repetitive Reverse Volta	age		600			V	
$I_{RM}$	Maximum Reverse Leakage Current	$V_{R} = 600V$				150	μA	
$I_{F}$	DC Forward Current		$Tc = 80^{\circ}C$		200		Α	
$V_{\rm F}$	Diode Forward Voltage	$I_F = 200A$ $V_{GE} = 0V$	$T_i = 25^{\circ}C$		1.6	2	V	
V <sub>F</sub>		$V_{GE} = 0V$	$T_{i} = 150^{\circ}C$		1.5		V	
+	t   Reverse Recovery Time		$T_j = 25$ °C		125		ng	
$\iota_{rr}$		$T_j = 150$ °C		220		ns		
0	Payarga Pagayary Charge	$V_{\rm p} = 3000 V_{\rm p}$		$T_j = 25$ °C		9.4		
$Q_{rr}$	Reverse Recovery Charge		$T_{\rm j} = 150^{\circ}{\rm C}$		19.8		μC	
E	Reverse Recovery Energy	•	$T_j = 25^{\circ}C$		2.2		mJ	
E <sub>r</sub>			$T_{j} = 150^{\circ}C$		4.8		1113	
$R_{thJC}$	Junction to Case Thermal Resistance					0.39	°C/W	



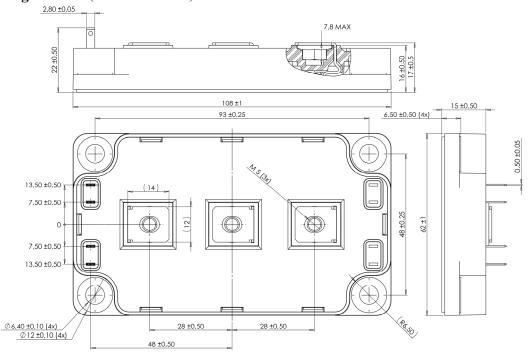
### SiC Parallel diode ratings and characteristics

Symbol	Characteristic	Test Condition	Min	Тур	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V
$I_{RM}$	Maximum Reverse Leakage Current	$V_R$ =600 $V$	$T_{j} = 25^{\circ}C$ $T_{j} = 175^{\circ}C$		400 800	1600 8000	μΑ
$I_{F}$	DC Forward Current		Tc = 100°C		80		A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 80A$ $T_i = 25^{\circ}C$ $T_j = 175^{\circ}C$			1.6	1.8 2.4	V
Qc	Total Capacitive Charge	$I_F = 80A, V_R = 600V$ di/dt = 2000A/ $\mu$ s			224		nC
	Total Capacitance	$f = 1 MHz, V_R = 200V$ $f = 1 MHz, V_R = 400V$			520		··F
Q					400		pF
$R_{thJC}$	Junction to Case Thermal Resistance				0.35	°C/W	

Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V		
$T_{J}$	Operating junction temperature range			-40	150			
$T_{JOP}$	Recommended junction temperature under	ons	-40	T <sub>J</sub> max -25	$^{\circ}\mathrm{C}$			
$T_{STG}$	Storage Temperature Range		-40	125				
$T_{\rm C}$	Operating Case Temperature				100			
Torquo	Maunting targue	To heatsink	M6	3	5	N.m		
Torque	Mounting torque	For terminals	M5	2	3.5	18.111		
Wt	Package Weight		·		300	g		

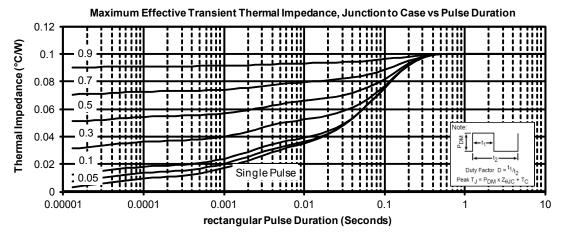
## SP6 Package outline (dimensions in mm)

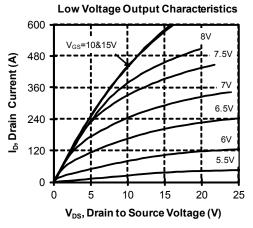


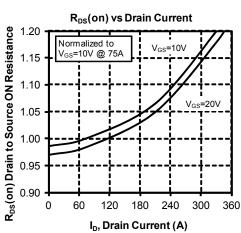
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

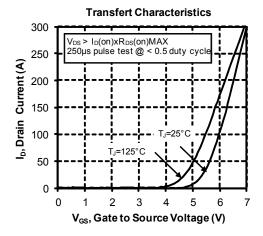


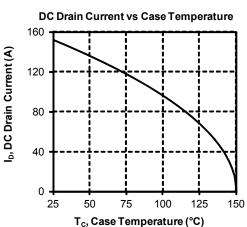
### **Typical MOSFET Performance Curve**



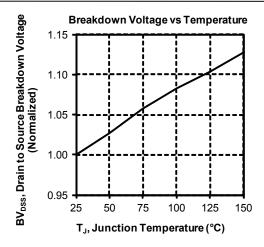


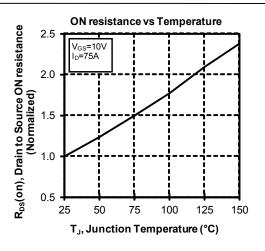


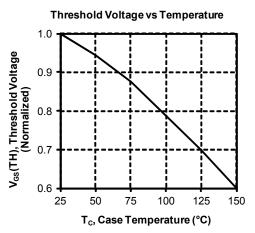




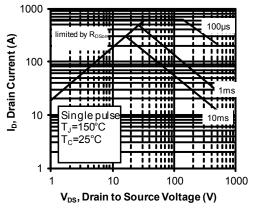


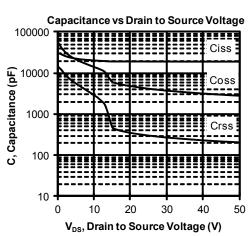


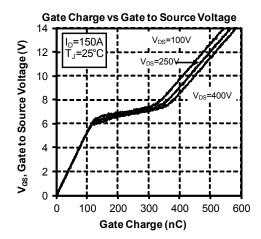




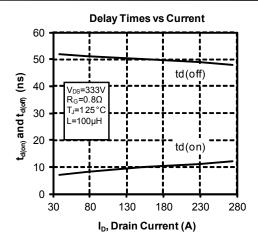


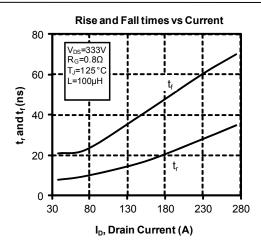


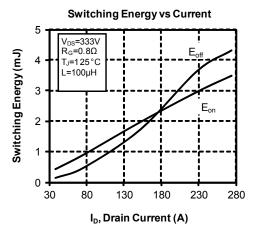


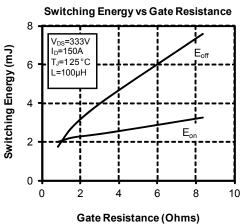




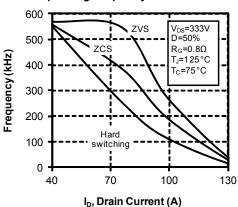






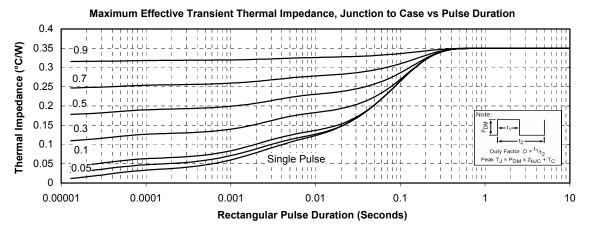


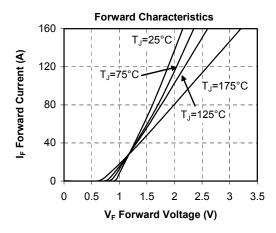


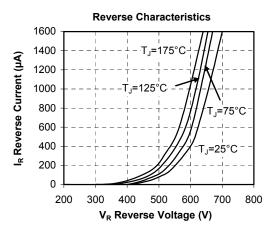


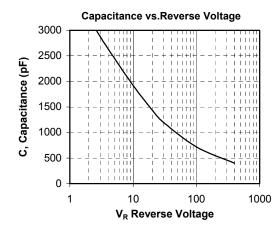


### **Typical SiC Diode Performance Curve**











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